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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Application Serial No.			10/620,468
Filing Date			July 15, 2003
Minventor			. Dinesh Chopra
Assignee		Micron	Technology, Inc
Group Art Unit			2822
Examiner			T. Trar
Attorney's Docket No.			MI22-234
Title: Conductive Cor	nnection Forming Methods	s, Oxidation Reducing Method	is, and Integrated
Circuits	Formed Thereby	-	_

INFORMATION DISCLOSURE STATEMENT PURSUANT TO 37 C.F.R. §§ 1.56, 1.97 AND 1.98

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patent reference listed on the attached Form PTO-1449. No admission is made regarding whether the submitted reference is prior art.

This Information Disclosure Statement is being filed before the mailing of a first Office Action on the merits. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. §1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Citation of this reference is respectfully requested.

Respectfully submitted,	
Dated: 17 Dec 2004 James E. Lake Reg. No. 44,854	

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET N MI22-2345		SERIAL NO. 10/620,468				
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										